SSF6072G5



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R	Junction-to-		38	W
	Junction-to-Ambient (PCB mounted, steady-state)		35	W

Electrical Characterizes @T_A=25 unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	60			V	$V_{GS} = 0V, I_D$
R _{DS(on)}	Static Drain-to-Source on-resistance		67	100		V _{GS} =10V,I _D = 1.5A
	Static Drain-to-Source on-resistance		76	115		V _{GS} =5V,I _D = 1.5A
V _{GS(th)}	Gate threshold voltage	1		2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 A$
1	B : 4 G			1		$V_{DS} = 60V, V_{GS} = 0V$
I _{DSS} Dra	Drain-to-Source leakage current			10		T _J = 125°C
	Cata ta Causa famound la la la ca			100	^	V _{GS} =20V
I _{GSS}	Gate-to-Source forward leakage			-100	nA	V _{GS} = -20V
gfs	Forward Transconductance	1			S	V _{DS} = 15 V I _D = 1.5A
Qg	Total gate charge		12			$I_D = 4A$,
Q _{gs}	Gate-to-Source charge		3.5		nC	V _{DS} =40V,
Q _{gd}	Gate-to-Drain("Miller") charge		3.7]	V _{GS} =10V
t _{d(on)}	Turn-on delay time		9.2			
t _r	Rise time		16.7			V _{GS} =10V, VDS=25V,
t _{d(off)}	Turn-Off delay time		35.4		ns	$R_{GEN}=50$ $I_{D}=1.2A$,
t _f	Fall time		8.6			
C _{iss}	Input capacitance		582			V _{GS} = 0V
C _{oss}	Output capacitance		49		pF	$V_{DS} = 30V$
C _{rss}	Reverse transfer capacitance		36		1	1MHz

Source-Drain Ratings and Characteristics

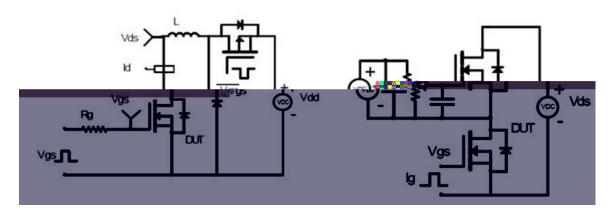
Symbol	Symbol Parameter		Тур. Мах.		Units	Conditions	
	Continuous Source Current			4	А	MOSFET symbol	
Is	(Body Diode)			4		showing the	
	Pulsed Source Current			40	۸	integral reverse	
Ism	(Body Diode)			16	A	p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.5	V	I _S =4A, V _{GS} =0V	



Test circuits and Waveforms

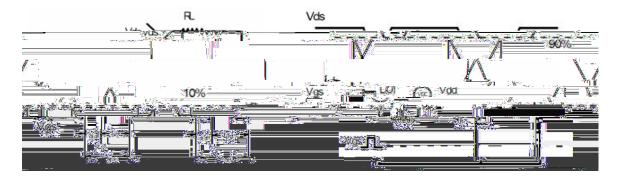
EAS Test Circuit:

Gate Charge Test Circuit:



Switching Time Test Circuit:

Switching Waveforms:



Notes:

The maximum current rating is limited by bond-wires.

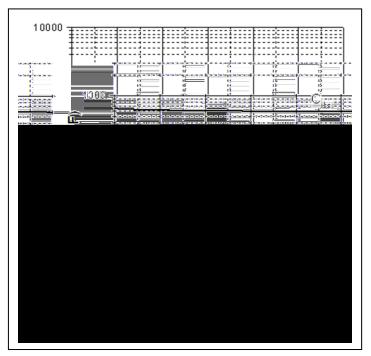
Repetitive rating; pulse width limited by max. junction temperature.

The power dissipation PD is based on max. junction temperature, using junction-to- ambient thermal resistance.

The value of R is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical Electrical and Thermal Characteristics



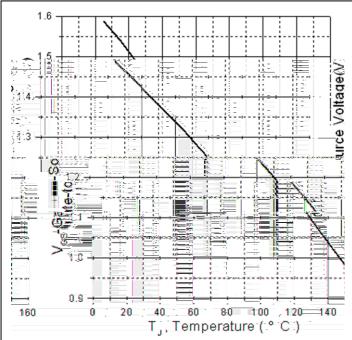
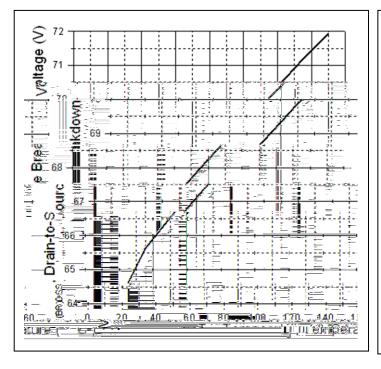


Figure 1. Typical Capacitance vs. Drain-to-Source Voltage

Figure 2. Gate to source cut-off voltage





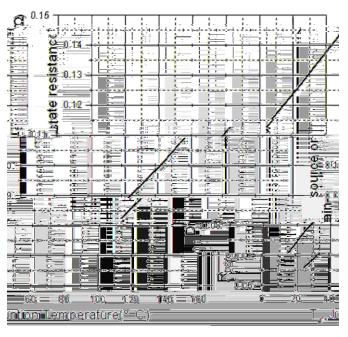
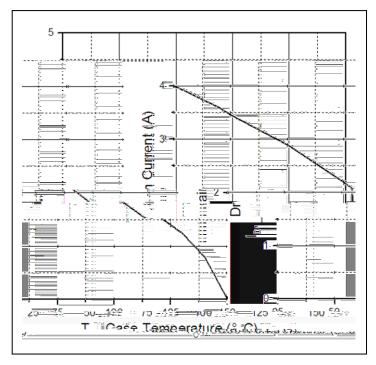


Figure 4. Normalized On-Resistance vs. Junction Temperature



Typical Electrical and Thermal Characteristics



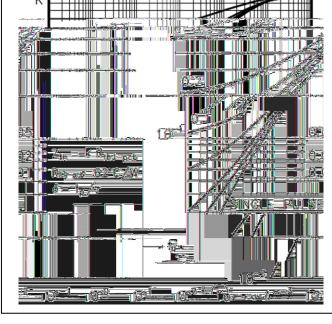


Figure 5. Maximum Drain Current vs. Case Temperature

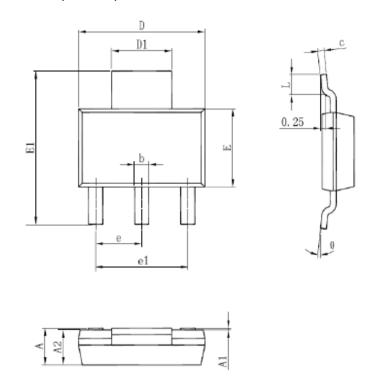
Figure 6. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Mechanical Data

Option 1

SOT-223 Dimensions (UNIT: mm)



Symbol	Dimensions In Millimeters		Dimensions		In Inches				
Symbol		Min		Max		Min		Max	
Α		1.520		1.800		0.060		0.071	
A1		0.000		0.100		0.000		0.004	
A2		1.500		1.700		0.059		0.067	
\$40 <u>7</u> 45000	2000	1.2% _		; = 1.7 € 2		_Ո Որո			-
5.359;***	::ò.::	—0:0%p=		E3H		\$, <u>.</u>	- − 0@50	y
8.400		÷	0 -2 82		D		6.2507 =		
3100	nco di carre		—842 <u>2 </u>				2:900:::::		
3:700=		0.1B0:		8.146				31300	
7.686		J. J. 2009 -		Acres 650018		er - 1811 - 1845		6.830	ì—
द शक्का		2:303(830) : : : :			0.681v	:==:::			
€:		4 500 =		/ #88÷		0.777		0.485****	
L		0.900=====		1.150		0.035		0.845	
1 hand 3		Ullimes		111111111111111111111111111111111111111		1001m 3.7%		initiation desired	

Notes

Dimensions are inclusive of plating

Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.

Dimension L is measured in gauge plane.

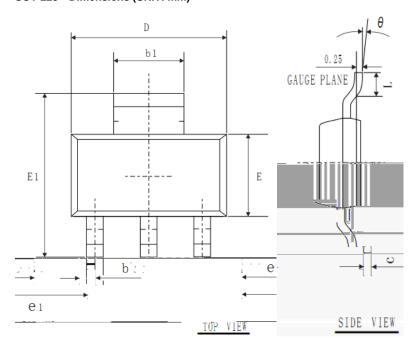
Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



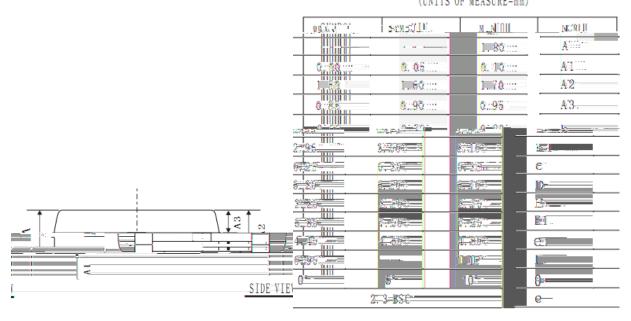
Mechanical Data

Option 2

SOT-223 Dimensions (UNIT: mm)



COMMON DIMENSIONS (UNITS OF MEASURE=mm)







ATTENTION:

Any and all Silikron products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your Silikron representative nearest you before using any Silikron products described or contained herein in such applications.

Silikron assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operatieratier(c)7(i)-4, liai(o)-3(s)-6(e)-3() 17(p)1 3569BT1 09-3(ft)-3(')(

©Silikron Microelectronics (Suzhou) Co.,Ltd

www.silikron.com

page 8 of 8